Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/674,684	BAIN ET AL.
Examiner	Art Unit

Rebecca L. Anderson

1626

	SEARCHED				
Class	Subclass	Date	Examiner		
544	143	3/18/2005	RA		
544	154	3/18/2005	RA		
514	235.2	3/18/2005	RA		
544	166	3/18/2005	RA		
514	231.2	3/18/2005	RA		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Name Search	3/18/2005	RA	
STN structure search (enclosed)	3/18/2005	RA	